Harmonic phase-dispersion microscope with a Mach–Zehnder interferometer

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Harmonic phase-dispersion microscopy (PDM) is a new imaging technique in which contrast is provided by differences in refractive index at two harmonically related wavelengths. We report a new configuration of the harmonic phase-dispersion microscope in a Mach–Zehnder geometry as an instrument for imaging biological samples. Several improvements on the earlier design are demonstrated, including a single-pass configuration and acousto-optic modulators for generating the heterodyne signals without mechanical arm scanning. We demonstrate quantitative phase-dispersion images of test structures and biological samples. © 2005 Optical Society of America

1. Introduction

Many biological samples exhibit little absorption at visible wavelengths and can be regarded as purely phase objects. Microscopy techniques such as phase contrast and differential interference contrast perform imaging of such objects by converting sample optical path delays into differences of intensity at the detector plane.1,2

Recently the technique of phase-dispersion microscopy (PDM) for imaging transparent biological samples was developed.3 In PDM, two beams that differ in wavelength by a factor of 2 are incident upon a Michelson interferometer, with the object of interest placed in the sample arm. One measures heterodyne signals for both wavelengths by scanning the reference arm, and the dispersion between the two wavelengths is calculated from the interferometer fringe patterns. This method was subsequently extended to imaging of three-dimensional systems, with a technique called phase-dispersion optical tomography.4 These techniques use the dispersion of biological materials as a source of contrast. Experiments showed that the phase-dispersion technique has considerable potential for biomedical imaging applications. However, the instrument was slow, requiring 3 h for a 100 × 100 pixel image, and the double-pass geometry through the sample made the device difficult to align and prone to errors.

In this paper we describe a new phase-dispersion microscope based on a Mach–Zehnder interferometer and using acousto-optic frequency shifting.

2. Experimental Setup

The setup (Fig. 1) contains two modules: beam preparation and a Mach–Zehnder interferometer. The light source is a diode-pumped continuous-wave doubled Nd:YAG laser with output at both the fundamental (λ1 = 1064 nm) and the second-harmonic (λ2 = 532 nm) wavelengths. The two beams are separated by dichroic mirror DCM1 and coupled into single-mode fibers by fiber couplers. At the output of the fibers the beams are collimated and are subsequently recombined by a second dichroic mirror, DCM2. The optical fibers ensure that the laser beams are nearly Gaussian in profile. In the interferometer module, beam splitter BS1 divides the two beams into sample and reference arms. In the sample arm the composite beam is focused onto the sample by a 20× microscope objective and, after passing through the sample, is recollimated by a second identical objective. The diameters of the focused beams were 13 and 4 μm for wavelengths λ1 and λ2, respectively, as we measured by scanning a knife-edge across the beams’ foci and measuring the transmitted power with photodiodes PD1 and PD2.
A bright-field microscope (lamp, lens L, and CCD) facilitates alignment. The sample is positioned by a three-dimensional motorized translation stage. The z-axis translation is used for adjusting focus, while the x and y axes are used to create the microscope image. To achieve frequency shifting without mechanically scanning one arm of the interferometer, we placed two acousto-optic modulators (AOMs) in the reference arm. The crystals are aligned such that AOM1 upshifts the optical frequency of the 1064-nm beam by 110 MHz (first-order beam) and that of the 532-nm beam by 220 MHz (second-order beam). The second AOM downshifts the optical frequency of the 1064-nm beam by 120 MHz (first-order beam) and that of the 532-nm beam by 240 MHz (second-order beam). The sample and reference arm beams are recombined by beam splitter BS2. The beams are split into component wavelengths by dichroic mirror DCM3, and ac-coupled photodetectors (New Focus 1801/1811) measure heterodyne signals at frequencies $\Delta \omega = 10$ MHz for $\lambda_1 = 1064$ nm and $2\Delta \omega = 20$ MHz for $\lambda_2 = 532$ nm.

The ac portions of the photodetector signals for beams $\lambda_1$ and $\lambda_2$ are given, respectively, by

$$V_1(t) \propto \cos[\Delta \omega t + k_1(\Delta L_1 + \delta s(t))],$$

$$V_2(t) \propto \cos[2\Delta \omega t + 2k_1(\Delta L_2 + \delta s(t))],$$

where $k_1 = 2\pi/\lambda_1$, $\Delta L_1 = \Delta L_1^S - \Delta L_1^R$, and $\Delta L_2 = \Delta L_2^S - \Delta L_2^R$ are the path-length differences between signal and reference arms at wavelengths $\lambda_1$ and $\lambda_2$, and $\delta s(t)$ accounts for interferometer phase noise that is due to external perturbations, such as air motion, vibrations, and thermal drift, which is assumed to be nondispersive. To measure the phase difference between the two arms we use a frequency doubler to double the signal $V_1(t)$, which yields

$$V_1^{d}(t) \propto \cos[2\Delta \omega t + 2k_1(\Delta L_1 + \delta s(t))].$$

Two phase-detector circuits (Analog Devices, AD-8302) are then used to measure the phase difference between signals $V_1^{d}(t)$ and $V_2(t)$, one measuring the in-phase quadrature and one (by means of a 90° delay line) measuring the out-of-phase quadrature. The measured phase difference is $\Delta \phi = 2k_1(\Delta L_1 - \Delta L_2)$ and, as the paths of the beams at wavelengths 1 and 2 are identical, any phase difference is due to differences in dispersion. Two-dimensional dispersion imaging is performed by in-plane scanning of the sample. As an unknown background dispersion exists as a result of the presence of various interferometer elements, all phase measurements shown here should be considered relative to other lateral points on the sample, not as absolute measurements of total sample dispersion.

The outputs of both phase detectors are digitized by a National Instruments analog-to-digital board and analyzed with LabVIEW software. An approximation in the algorithm that is used to demodulate the phase...
detection outputs introduces an error of \( \pm 0.071 \, \text{rad} \) in the calculation. The LabVIEW program also controls the motors of the scanning stages and records data.

3. Experimental Results

To verify the dispersion measurements quantitatively, we obtained PDM data from a rectangular phase grating made from BK7 glass (Fig. 2). The rectangular profile had a height of 1.064 \( \mu \text{m} \) with a 75-\( \mu \text{m} \) pitch. The refractive indices of BK7 at 1.064- and 0.532-\( \mu \text{m} \) wavelengths are 1.506 and 1.519, respectively. The PDM measurement gave 0.22 \( \pm 0.07 \, \text{rad} \), in good agreement with the expected value of 0.21 rad. The spikes associated with the edges of the grooves may reflect either size mismatch of the two beams or a small lateral misalignment.

Figure 3 illustrates the phase-dispersion image retrieved from a polystyrene bead 40 \( \mu \text{m} \) in diameter. The beads were immersed in glycerol and sandwiched between two glass coverslips. Because of the large size of the diameter relative to the wavelength, the measured phase dispersion exceeded \( 2\pi \). This phase-wrapping effect is illustrated by the concentric rings in Fig. 3(a); Fig. 3(c) shows the result after a numerical phase-unwrapping procedure was applied. Vertical cross sections of these images are presented in Figs. 3(b) and 3(d), respectively. The ghost image to the lower right of the bead may have been caused by stray reflections from dichroic mirror DCM1 or from the same edge effect observed in the grating image.

A PDM image of a layer of onion skin is shown in Fig. 4. The cell boundaries and substructures are resolved by our technique with high contrast.

4. Discussion

The configuration presented here represents an improvement over the earlier Michelson setup in a number of ways. The single-pass setup greatly simplifies the optical alignment and reduces ghosting effects from slight misalignment of the Michelson beam. Heterodyne signals are created by acousto-optic modulators instead of by piezoelectric transducer scanning of a mirror. This gives a continuous heterodyne signal, and several limitations of the piezoelectric transducer crystal, such as hysteresis and creep, are avoided. In addition, the heterodyne frequency obtained is much higher, which reduces the sensitivity of the instrument to 1/\( f \) noise and allows faster data acquisition. Moreover, phase detection is performed in hardware instead of software as in the earlier version, which both limited the heterodyne frequency and caused delays for signal processing. As a result of these improvements, images can be obtained at a rate of 50 ms/pixel, compared with 1000 ms/pixel in the earlier system. In these experiments laser intensity noise problems prevented us from achieving a much higher data acquisition rate, of the order of 1 ms/pixel. We intend to attempt to increase the imaging rate further and explore techniques for whole-field phase imaging.

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References


